

Application No.	Applicant(s)	· · ·
09/823,759	YEN ET AL.	
Examiner	Art Unit	
Nhon (Garv) D Nguyen	2179	

SEARCHED				
Class	Subclass	Date	Examiner	
715	716, 737, 740, 761	12/2/2004	NN	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Searched in USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM-TDB and NPL.	12/2/2004	NN
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